

Laser and Optics Advanced R&D

Jordan Camp

May 1, 2000

LIGO II Laser Requirements

- Power: 180 W
- Mode Shape: 90% of light in TEM₀₀ mode
- Frequency Noise: 5×10^2 Hz / sqrt (Hz)
- Intensity Noise: 1×10^{-5} / sqrt (Hz)
- Stability: 1%

Path to 180 W Laser

- MOPA (Master Oscillator Power Amplifier)
 - ›› under development at Stanford University
 - ›› 30W TEM₀₀ output power achieved using LIGO I laser as MO
 - ›› investigation of intensity noise at various levels of gain saturation
 - ›› modeling of thermal management key to advance in power
- Injection Locked Stable - Unstable Resonator
 - ›› under development at Adelaide University, Australia
 - ›› 30W unstabilized output power achieved
 - ›› effort to injection lock resonator continuing

Industrial Vendors

- Markets growing for 100 W class IR laser
 - ›› laser diode price dropping rapidly
- Letter of Solicitation of Interest sent to 12 laser companies
 - ›› included 180 W laser specifications document
 - ›› response from Lightwave Electronics (LIGO I laser builder), TRW
 - ›› verbal response from Laser Zentrum / Hannover
- Time frame for laser fabrication
 - ›› industrial R&D in 01
 - ›› fabrication in 02, integration in LIGO II subsystem in 03

Sapphire Optics for LIGO II

- Low Internal Thermal Noise

- ›› $Q \sim 4 \times 10^8$

- ›› Thermoelastic noise lower limit to low frequency noise (factor ~ 5 below fused silica)

- Increased Density

- ›› reduced radiation pressure noise

- Optical performance must satisfy LIGO II requirements

- ›› $G_{rc} = 100$

- ›› Arm cavity stored power = 700 kW

Sapphire Development in 2000

- Measure optical and mechanical properties of small sapphire samples
 - ›› Q
 - ›› optical homogeneity
 - ›› ability to polish
 - ›› absorption
 - ›› birefringence of coatings
- Feed back information to Crystal Systems to grow full size pieces for 2001
- An LSC effort: Caltech, Stanford, Glasgow, Syracuse

Q and Loss Measurements

- Measure Q's $> 10^8$ for a variety of sapphire pieces
 - ›› effect of polish
 - ›› effect of coating, attachments
- Cross check measurements with different groups
 - ›› Caltech, Stanford, Glasgow
- Anelastic low frequency loss studies at Syracuse
 - ›› few $\times 10^{-7}$ loss measurement now
 - ›› development proceeding to loss levels of interest for sapphire
 - ›› effect of coating, surface loss

Polish and Optical Homogeneity

- LIGO II recycling gain ~ 100 requires:
 - ›› optics surface figure 1 nm rms
 - ›› microroughness 0.1 nm rms
 - ›› bulk homogeneity 10 nm rms
 - requires compensating polish of back surface
- Polish tests
 - ›› CSIRO
 - ›› General Optics
 - ›› metrology supported by Caltech Fizeau interferometer

Bulk Absorption

- Nominal sapphire absorption 40 ppm / cm
 - ›› requires factor 50 reduction in bulk distortion through adaptive thermal compensation
- Program to identify and eliminate sources of absorption
 - ›› Stanford Photothermal Common-Path Interferometer
 - ›› examine samples from different sapphire starting materials, locations in boule, annealing processes, etc.
 - ›› measured absorption 40 - 120 ppm
 - ›› absorption due to Ti, other impurities

Coating Absorption and Birefringence

- LIGO II coating requirements
 - ›› birefringence $< 10^{-3}$ rad
 - ›› absorption < 1 ppm
- Measure by probing resonant cavity with transmitted sideband as function of input polarization
 - ›› low loss coating possible on c-axis sapphire
- Determine if m-axis sapphire optics are practical
 - ›› m-axis anisotropy may stress coating
 - ›› c-axis sapphire requires double-size boule

Schedule of Tests

Sapphire Development Tests for 2000

| # | Axis | Size | Test | Dates | Place |
|----|------|-------------------------|--|-------------|-------------------|
| 1 | m | 15 cm ϕ x 8 cm | Optical Homogeneity and Surface Figure Q | May - July | CSIRO |
| | | | | July - Aug | Caltech, Stanford |
| 1 | m | 15 cm ϕ x 8 cm | Optical Homogeneity and Surface Figure Q | May - July | GO |
| | | | | July - Aug | Caltech, Stanford |
| 2a | m | 25 cm ϕ x 10 cm | Q Surface Figure Coating Stress Birefringence Q | June - July | Stanford, Caltech |
| | | | | Aug - Sept | - |
| | | | | Oct | Caltech |
| | | | | Nov - Dec | Caltech, Stanford |
| 2b | m | 7.5 cm ϕ x 3 cm | Coating Stress Birefringence | June | Caltech |

Tests (cont.)

| # | Axis | Size | Test | Dates | Place |
|---|------|-------------------------|--|-------------|-------------------------------|
| 3 | m,c | 1 cm x 1 cm x 1 cm | Bulk Absorption | Mar - Dec | Stanford |
| 4 | m,c | 2.5 cm ϕ x 1 cm | Coating Absorption Coating Stress Birefringence | May May | Caltech Caltech |
| 5 | m,c | 3 cm ϕ x 10 cm | Q and Silicate Bonding | May - Aug | Stanford, Glasgow |
| 6 | m,c | 13 cm ϕ x 6 cm | Q and Coating | April - Aug | Stanford, Glasgow, Caltech |